

This article was downloaded by:

On: 19 January 2011

Access details: *Access Details: Free Access*

Publisher *Taylor & Francis*

Informa Ltd Registered in England and Wales Registered Number: 1072954 Registered office: Mortimer House, 37-41 Mortimer Street, London W1T 3JH, UK



International Journal of Polymeric Materials

Publication details, including instructions for authors and subscription information:

<http://www.informaworld.com/smpp/title~content=t713647664>

Dielectric Spectroscopy of Polycarbosilazane-based CuCl_2 Metallopolymers

I. M. Arafa^a; H. M. El-Ghanem^b; A. B. Hallak^c; S. Abdul Jawad^c

^a Department of Applied Chemistry, Faculty of Sciences and Arts, Jordan University of Science and Technology, Irbid, Jordan ^b Department of Physics, Faculty of Sciences and Arts, Jordan University of Science and Technology, Irbid, Jordan ^c Department of Physics, The Hashemite University, Faculty of Sciences and Arts, Zarqa, Jordan

To cite this Article Arafa, I. M. , El-Ghanem, H. M. , Hallak, A. B. and Jawad, S. Abdul(2005) 'Dielectric Spectroscopy of Polycarbosilazane-based CuCl_2 Metallopolymers', *International Journal of Polymeric Materials*, 54: 9, 857 – 870

To link to this Article: DOI: 10.1080/00914030490499314

URL: <http://dx.doi.org/10.1080/00914030490499314>

PLEASE SCROLL DOWN FOR ARTICLE

Full terms and conditions of use: <http://www.informaworld.com/terms-and-conditions-of-access.pdf>

This article may be used for research, teaching and private study purposes. Any substantial or systematic reproduction, re-distribution, re-selling, loan or sub-licensing, systematic supply or distribution in any form to anyone is expressly forbidden.

The publisher does not give any warranty express or implied or make any representation that the contents will be complete or accurate or up to date. The accuracy of any instructions, formulae and drug doses should be independently verified with primary sources. The publisher shall not be liable for any loss, actions, claims, proceedings, demand or costs or damages whatsoever or howsoever caused arising directly or indirectly in connection with or arising out of the use of this material.

Dielectric Spectroscopy of Polycarbosilazane-based CuCl_2 Metallopolymers

I. M. Arafa

Department of Applied Chemistry, Faculty of Sciences and Arts,
Jordan University of Science and Technology, Irbid, Jordan

H. M. El-Ghanem

Department of Physics, Faculty of Sciences and Arts,
Jordan University of Science and Technology, Irbid, Jordan

A. B. Hallak

S. Abdul Jawad

Department of Physics, The Hashemite University,
Faculty of Sciences and Arts, Zarqa, Jordan

A series of poly (carbosilazane- CuCl_2) metallopolymers was prepared by the reaction of varying amounts (5% to 30%) of anhydrous CuCl_2 with polycarbosilazane, $[-(\text{CH}_3)_2\text{SiNH}(\text{CH}_2)_2\text{NH}-]_n$, matrix in tetrahydrofuran under continuous sonication. Dielectric measurements were performed at room temperature (25°C) in the frequency range 1 Hz to 10^6 Hz. It was found that the ac conductivity increases with increasing the CuCl_2 up to 16% and then starts to dramatically decrease. The results reveal that all the dielectric parameters such as ac impedance, dielectric permittivity, and electric modulus behave similar to that observed in ac conductivity. (i.e., maximum or minimum depends on the considered dielectric parameter). It is suggested that at low concentration of metal content, all the CuCl_2 is uniformly bound to the backbone of the polymer chains, where the conduction mechanism in the system is by electrons jumping (carrier hopping between the chains), whereas at high metal content the coordination capacity of the backbone is exceeded and CuCl_2 is present as molecular clusters that lead to an increase in the interaction distances, and make hopping between chains more difficult, and hence, resulting in a reduction of conductivity.

Keywords: polycarbosilazane, metallopolymer, organosilicon polymer, dielectric permittivity, electric modulus, relaxation transition

Received 4 May 2004; in final form 17 May 2004.

This work was gratefully supported by Jordan University of Science & Technology, Irbid, Jordan.

Address correspondence to H. M. El-Ghanem, Department of Physics, Faculty of Sciences and Arts, Jordan University of Science and Technology, P.O. Box 3030, Irbid 22110, Jordan. E-mail: hmel@just.edu.jo

INTRODUCTION

The past few years have witnessed an increasing interest in metallomesogenes, metallopolymers, and other metal-containing macromolecules [1–11]. This interest stems from their potential applications in modern technology such as liquid crystals, electrical, optical, opto-electronic, ferroelectric, ferromagnetic, as well as catalysis [1–6]. The incorporation of metal ions, complexes, and clusters in macromolecular systems is reported to produce significant changes in their structures and properties. In these materials the metal center is chemically attached to the surface of the polymer via σ or π bonds at regular inter-spaces or randomly dispersed in the polymeric matrix [1–6]. The former class provides a unique macromolecular system to study numerous electronic processes. Such systems carry many advantages; they can be prepared in a variety of structures and can be structurally modified to be tuned to the desired property. In addition they can be formulated as thin films, fibers, and membranes at relatively low temperatures.

In a series of articles, the present authors have shown that different divalent, trivalent, and mixed valence transition metals can be covalently attached to polycarbosilazane-containing diamino groups such as $[-(\text{CH}_3)_2\text{SiNH}(\text{CH}_2)_2\text{NH}-]_n$, PDMSEN [12–14]. In this system, the backbone structure is composed of alternating carbosilazane units. The present article reports on the dielectric behavior of PDMSEN containing varying amounts of CuCl_2 , in the frequency range 1 Hz to 10^6 Hz. Different dielectric parameters will be discussed such as ac conductivity, permittivity, loss factor, impedance, and electric modulus. It is important to note that some applications for metallopolymers require materials with well-separated metal sites (low metal content) whereas others need agglomerated metal clusters (high metal contents).

EXPERIMENTAL

Materials

All chemicals and solvents were reagent grade and used as received without further purification unless otherwise stated [$(\text{CH}_3)_2\text{SiCl}_2$ (99%, Acros), ethylenediamine, (99%, Janssen Chimica), CuCl_2 , (Merck) and triethylamine (98%, Scharlau)].

Synthesis of $[-\text{Si}(\text{CH}_3)_2\text{NHCH}_2\text{CH}_2\text{NH}-]_n$ Matrix (PDMSEN)

The general method used to produce $[-\text{Si}(\text{CH}_3)_2\text{NHCH}_2\text{CH}_2\text{NH}-]_n$ polymer was previously described [12–16]. In this method, equimolar

amounts of $(\text{CH}_3)_2\text{SiCl}_2$ and $\text{H}_2\text{NCH}_2\text{CH}_2\text{NH}_2$ in toluene in the presence of Et_3N were refluxed under nitrogen for 4–5 h. The product was isolated from toluene under reduced pressure to yield a creamy-waxy solid. The average molecular weight (M_n) was found to be 2300 g/mole, $n = 20$ (vapor pressure osmometry, benzene, 35°C).

Incorporation of CuCl_2 into the PDMSSEN Matrix

These metallopolymers were prepared in THF using different wt/wt ratios of CuCl_2 and PDMSSEN (5%, 10%, 16%, 20%, 26%, and 30%). In general, the CuCl_2 and PDMSSEN were separately dissolved in THF and mixed in a round-bottom flask. The reaction mixture was subjected to heating (70 – 75°C for 2 h) in a sonicating bath. The yellow–light green products were precipitated by the addition of hexane, filtered off and eventually dried under vacuum at room temperature for several hours.

X-Ray Diffraction

Powder X-ray diffraction (XRD) was performed using a PW 1729 Philips diffractometer interfaced with a computer control unit model PW 1710 using copper source (K_α radiation, $\lambda = 1.54 \text{ \AA}$). The diffraction patterns were recorded using a PM 8203A one line recorder. The angular range of 2θ was taken between 3° and 80° because no peaks were observed below 3° for all samples. The scanning speed of the diffractometer was in 0.02° – 0.04° ($2\theta/\text{s}$) depending on the quality of signal-to-noise ratio. The positions of the peaks were determined by curve-fitting procedure of the experimental XRD data using Table Curve-2D software (Lowess Algorithm).

AC Measurements

Samples of PDMSSEN—containing different concentrations of CuCl_2 (5% to 30%), about 0.2 g of very fine powder—were compressed at $10 \text{ ton}\cdot\text{cm}^{-2}$ for 10 min forming circular discs 13 mm in diameter and varied thickness between 0.5 to 1 mm. A silver coating was applied to each surface of the disc. Then it was sandwiched between two brass circular discs to ensure good ohmic contacts with brass electrodes.

The ac measurements were performed in the frequency range between 1 Hz and 10^6 Hz at room temperature using a 1260 Impedance Gain Phase Analyzer (Solartron Analytical). The system was controlled using the Z-60 and Z-View Packages, which maximize the performance and data handling of the system. The generator

amplitude was kept at 0.5 rms volts and 0 dc bias. The complex ac impedance and the phase angle were measured, while the real and imaginary components of dielectric constant, impedance, electric modulus were calculated [15].

RESULTS AND DISCUSSION

Figures 1a and 1b show the dependence of the real and imaginary components of ac impedance on frequency at zero dc bias for different concentrations of CuCl_2 . The general features for the samples containing 5%, 10%, and 16%, are similar to that observed for RC-network in parallel. At low frequencies, the real component of ac impedance (Z') is nearly independent of frequency and attains a minimum value for the sample containing 16% of CuCl_2 , indicating that this sample possesses the highest conductivity. In the frequency range between 10 Hz and 1 kHz, a sharp drop in the real component of ac impedance was observed for all samples with a well-defined relaxation peak in the plot of the imaginary component of ac impedance especially for samples containing 5% to 20% of CuCl_2 , as shown in Figure 1b. However, the intensity of the peaks decreases with increasing amounts of CuCl_2 ,

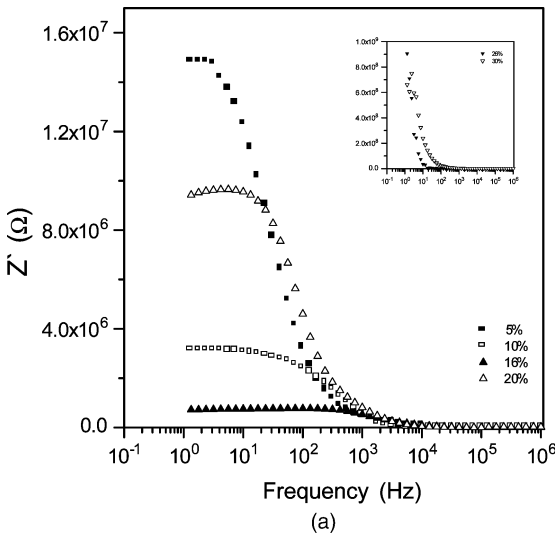


FIGURE 1 (a) Real (Z') component of impedance versus frequency for polycarbosilazane-based CuCl_2 . (b) Imaginary component (Z'') of impedance versus frequency for polycarbosilazane-based CuCl_2 . (c) Real (Z') versus imaginary (Z'') of impedance for polycarbosilazane-based CuCl_2 .

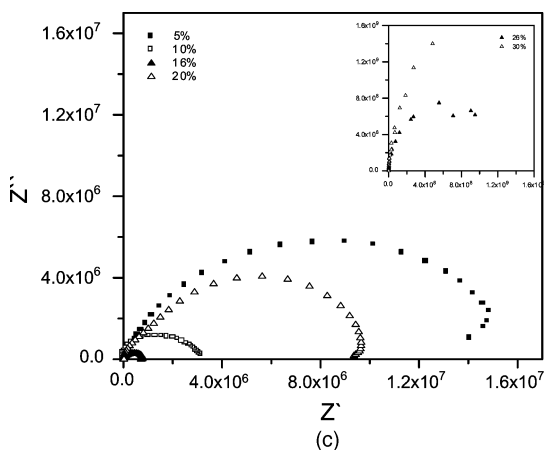
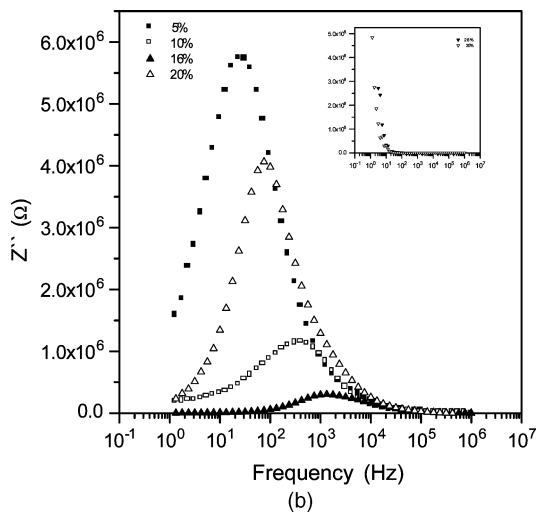


FIGURE 1 Continued.

and moves to higher frequency. For the sample that contains 20% CuCl_2 , the intensity of the peak starts to increase and moves to a lower frequency. The peak completely disappears in the samples that contain 26% and 30% of CuCl_2 . The plot of the real component (Z') versus imaginary component (Z'') is shown in Figure 1c. Nearly perfect semi-circles were observed in the samples that contain 5%, 10%, and 16%, and some distortion in the semi-circles was detected in the sample containing 20%. For high concentrations that is, 26% and 30%, no

semi-circles were detected. The radius of the semicircles in the plot of Z' versus Z'' represent the bulk resistance (R), where the conductivity (σ) can be determined using the relation,

$$\sigma = L/RA$$

where L is the sample thickness, and A is the sample area.

The calculated values of conductivity are shown in Figure 2. The conductivity increases with increasing CuCl_2 content up to about 16% and attaining a maximum value of $3.6 \times 10^{-6} (\Omega \cdot \text{m})^{-1}$. Then it starts to decrease to a value of $3 \times 10^{-9} (\Omega \cdot \text{m})^{-1}$ for the sample that contains 30%. The incorporation of anhydrous CuCl_2 into $[-(\text{CH}_3)_2\text{SiNH}(\text{CH}_2)_2\text{NH}-]_n$ matrix was performed using a typical literature procedure in a THF solution in a sonicating bath, as shown in Scheme 1 [12].

It is well established that the structure of PDMS-SEN chain is linear, and is composed of alternating $(\text{CH}_3)_2\text{SiNHCH}_2\text{CH}_2\text{NH}-$ carbosilazane units with strong affinity for binding transition metal ions [12, 14, 16]. However, the maximum capacity of such material to hold metal ions is dictated by the number of binding sites on its surface. At low metal content, all the CuCl_2 is uniformly bound to the backbone and therefore the metal sites are separated by insulating barriers at regular inter-spatial distances. Consequently, conduction through a single type of structure is expected. At 16% all the binding sites are occupied where the conductivity attains its maximum value. By

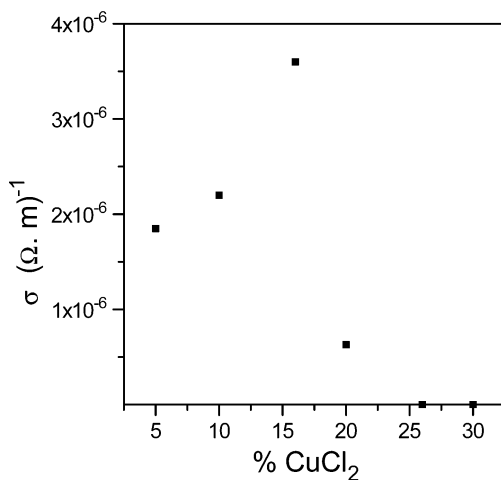
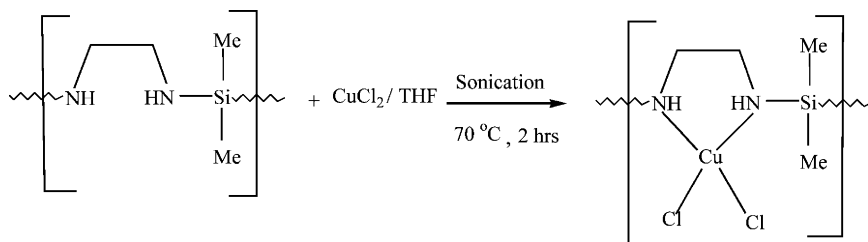


FIGURE 2 AC conductivity versus CuCl_2 content in polycarbosilazane-based CuCl_2 .



SCHEME 1 Incorporation of CuCl_2 in polycarbosilazane polymer.

increasing the metal content the coordination capacity of the backbone is exceeded. Therefore, two possibilities may arise, after the chains hold their maximum capacity, the excess CuCl_2 aggregates/clusters will be physically entrapped in the entire matrix. In this case two structural forms of CuCl_2 coexist and consequently, two conduction mechanisms operate at higher metal content. Alternatively, aggregates/clusters of CuCl_2 are held covalently at diamino groups of the carbosilazane backbone to form a different macromolecular structure and eventually one conduction regime operates. It is important to point out that sonication of the reacting mixture assists in obtaining uniform particle size distribution and inter-particle spacing. Information about the packing of PDMSSEN chains and CuCl_2 clustering was obtained from powder XRD data. The powder X-ray diffraction (XRD) profiles for the PDMSSEN matrix, pure CuCl_2 and all the PDMSSEN- CuCl_2 systems are shown in Figure 3. Each XRD pattern of the PDMSSEN matrix contains three broad peaks ($2\theta = 8.00^\circ$, 14.95° , and 28.50°), which demonstrates that it is predominantly amorphous in nature with small crystalline regions. The average chain-chain distance in PDMSSEN was estimated from the main broad peak centered at $2\theta = 14.95^\circ$ using Bragg's law ($n\lambda = 2d \sin \theta$) and found to be 6.88 \AA [17, 18, 19]. Examination of the XRD patterns of these PDMSSEN- CuCl_2 macromolecules show that they are composed of two diffraction sets, the broad peaks of the PDMSSEN amorphous phase and a set of sharp peaks due to the crystalline phase of the coordinated CuCl_2 . In fact, at low CuCl_2 concentration (below 20%) the diffraction patterns demonstrate that all CuCl_2 are chemically attached to the PDMSSEN matrix and therefore exhibit a diffraction peaks different from that of pure CuCl_2 . However, the XRD profiles of PDMSSEN- CuCl_2 containing high concentration of CuCl_2 (above 20%) display an additional set of diffraction peaks that correspond to fine CuCl_2 clusters. Moreover, the shift in the position of the main broad peak of the PDMSSEN matrix ($2\theta = 14.95^\circ$) to lower 2θ values

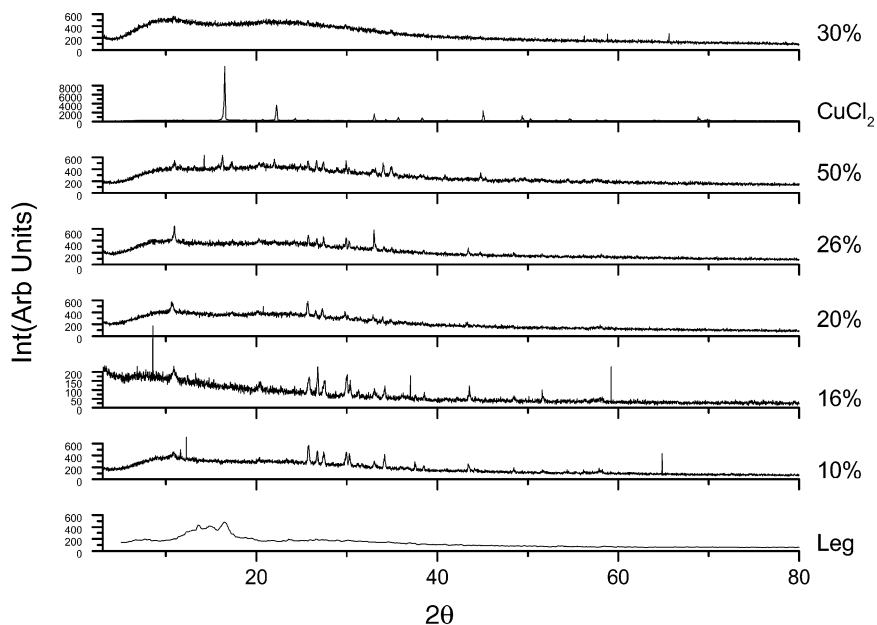


FIGURE 3 Powder X-ray diffraction for PDMSSEN matrix, pure CuCl_2 crystalline and all PDMSSEN- CuCl_2 macromolecules.

provide a strong evidence for an increase in the chain-chain distances in all PDMSSEN-Cu chloride macromolecules as given in Table 1. This clearly suggests that the CuCl_2 is incorporated between the PDMSSEN chains and therefore has caused chain-chain expansion to different extents depending on the amounts of CuCl_2 introduced. It is interesting to note that chain-chain separation systematically increased from 6.880 Å (PDMSSEN) to 8.266 Å (20% CuCl_2) then became practically constant as $\text{CuCl}_2\%$ increased from 26 to 50%. This observation can be explained on the basis of the proposition that the inserted CuCl_2 into the PDMSSEN matrix has caused an increase in the chain-chain separation up to a certain concentration (20% CuCl_2) above which CuCl_2 tends to form aggregates of fine CuCl_2 clusters filling the voids between PDMSSEN chains (percolation). It is important to emphasize that at higher concentration (above 20%) sharp peaks due to pure CuCl_2 crystallites are observed. The relative amounts of entrapped CuCl_2 crystallites can be estimated from the area under the main peak of CuCl_2 diffraction patterns at $2\theta = 17.2^\circ$. These values demonstrate that in the case of 10% and 16% all CuCl_2 is bonded to the matrix whereas at higher concentrations the introduced CuCl_2 is present in

TABLE 1 Selected XRD Data for the PDMSEN- CuCl_2 Macromolecules-Containing Varying Amounts of CuCl_2

% CuCl_2 introduced in PDMSEN matrix	$2\theta(^{\circ})^a$	$d(\text{\AA})$	% CuCl_2 fine crystallites physically entrapped in the PDMSEN matrix ^d	% CuCl_2 chemically attached to the PDMSEN matrix ^e
PDMSEN	14.95	6.880	<i>b</i>	—
10	10.90	8.107	<i>b</i>	10
16	10.88	8.122	<i>b</i>	16
20	10.69	8.266	5.4	14.6
26	10.91	8.100	8.9	17.1
30	10.95	8.074	<i>c</i>	<i>c</i>
40	10.98	8.048	15.8	24.2
50	11.03	8.011	24.6	25.4

^a 2θ values of the main broad peak due to PDMSEN matrix. ^bPure CuCl_2 crystallite lattices are not detected. ^cVery broad. ^dThe % of CuCl_2 crystallite entrapped into the PDMSEN- CuCl_2 macromolecules normalized to the main sharp peak of CuCl_2 . ^eThe amounts of CuCl_2 chemically attached to the PDMSEN matrix can be calculated from the difference between columns 1 and 4.

two forms, chemically bonded to the PDMSEN matrix and physically entrapped into the matrix as shown in Table 1. Moreover, as the amounts of pure CuCl_2 increase beyond 26%, the inter-chain spacing remained almost constant, Figure 4, suggesting that CuCl_2 crystallites grow uniaxially with PDMSEN chain direction, thus causing no further inter-chain space expansion.

The dependence of relative permittivity (ϵ') on frequency is shown in Figure 5a, where the ϵ' is minimum for samples that contain high contents of CuCl_2 . The sharp increase in dielectric permittivity (ϵ') at low frequency and dielectric loss (ϵ'') as shown in Figure 5b are mainly due to ionic conduction. However no relaxation peak was observed in the plot of the loss factor (ϵ'') shown in Figure 5b. It is believed that the ion conduction may mask any relaxation. Therefore, to analyze the conductivity relaxation process, the complex permittivity ϵ^* is converted to the complex electric modulus M^* according to the following relations (Macedo et al.) [20].

$$M' = \epsilon' / \epsilon'^2 + \epsilon''^2$$

$$M'' = \epsilon'' / \epsilon'^2 + \epsilon''^2$$

In these relations, ϵ' appears as in the denominator to the second power, and its tendency to overwhelm the loss factor is minimized. In addition, the electric modulus can explain the dispersion of ϵ^* with

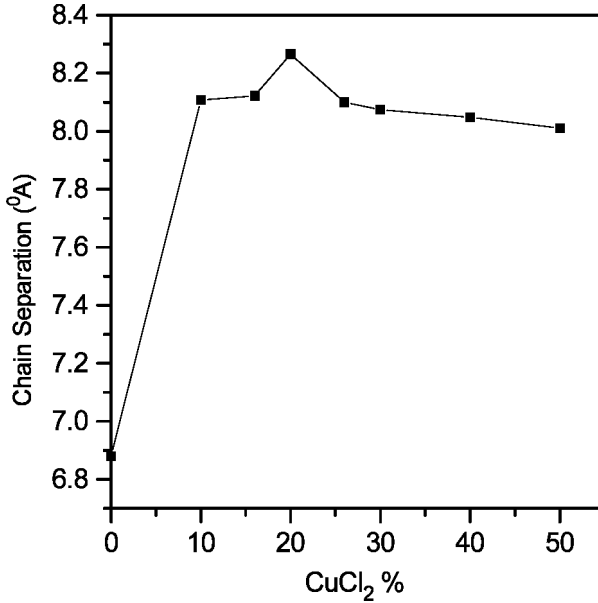


FIGURE 4 A plot of PDMS/EN chain-chain separation as a function of $\text{CuCl}_2\%$.

frequency without any molecular polarization phenomena. From the dependence of M' and M'' on frequency as shown in Figures 6a and 6b, the dispersion of M' and M'' indicates the presence of the relaxation time distribution of conduction. M' in Figure 6a for samples containing 5% to 16% of CuCl_2 approaches zero at low frequencies indicating that electrode polarization gives a negligible low contribution to M' and can be ignored. The peak maxima of the M'' for CuCl_2 contents decrease in intensity and move toward higher frequencies. This coincides well with the results of Lee et al. [21] who found that in doped polymers, the peak shifts toward higher frequencies with increasing dc conductivity. However, Broad peaks were observed for all samples that may involve two relaxation processes. This is clear in the sample that contains 5% of CuCl_2 , where two relaxation processes can be detected. This is clearly demonstrated in the plot of M' versus M'' , where two semi-circles were observed in the low content of CuCl_2 , as shown in Figure 6c.

Concerning the dielectric permittivity, Hourquebie and Olemo [22] suggested the following formula for the dependence of ϵ'' on frequency

$$\epsilon''(f) \propto f^{-n}$$

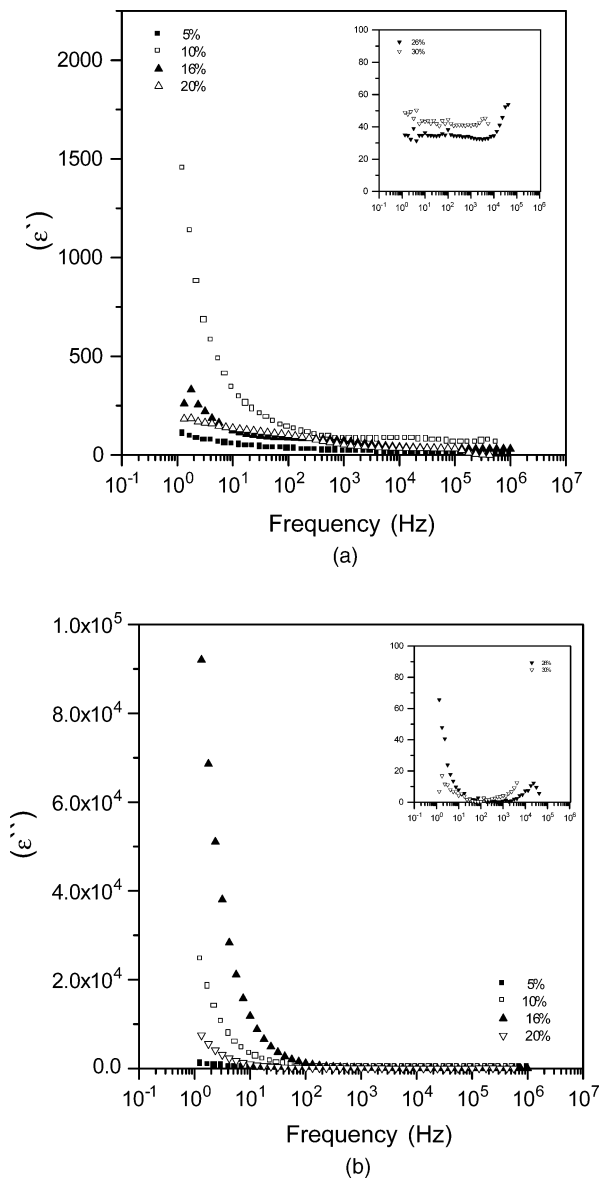
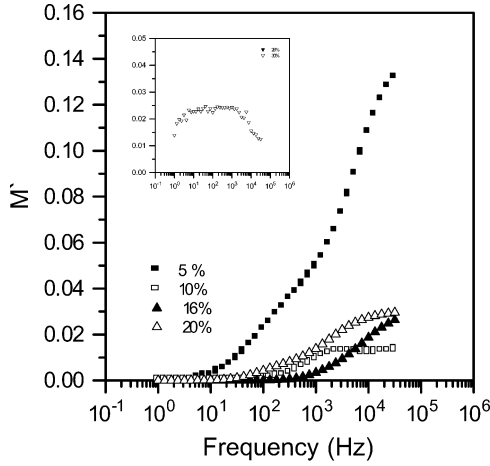
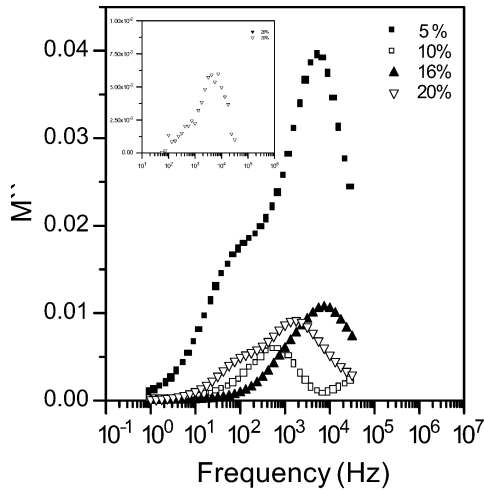


FIGURE 5 (a) Dielectric permittivity (ϵ') versus frequency for polycarbosilazane-based CuCl_2 . (b) Dielectric loss (ϵ'') versus frequency for polycarbosilazane-based CuCl_2 .



(a)



(b)

FIGURE 6 (a) Real (M') component of electric modulus versus frequency for polycarbosilazane-based CuCl_2 . (b) Imaginary component (M'') versus frequency for polycarbosilazane-based CuCl_2 . (c) Real (M') versus imaginary component (M'') of electric modulus for polycarbosilazane-based CuCl_2 .

Figure 7 shows the plot of $\log \epsilon''$ versus frequency for the samples that contain up to 16% CuCl_2 . The experimental curves in the frequency range 200 Hz to 10^4 Hz, show good linearity, Therefore this formula is convenient to calculate ϵ'' for this frequency range. Calculated (n)

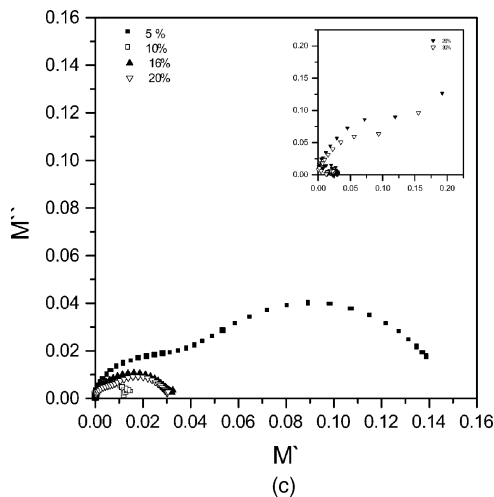


FIGURE 6 Continued.

for the samples that contain 5%, 10%, and 16% CuCl_2 give the values of (n) as 0.87, 0.95, 0.96, respectively. Thus the conductivity would be nearly $\sigma \propto f^{-0.94}$ indicating that the conductivity should increase with

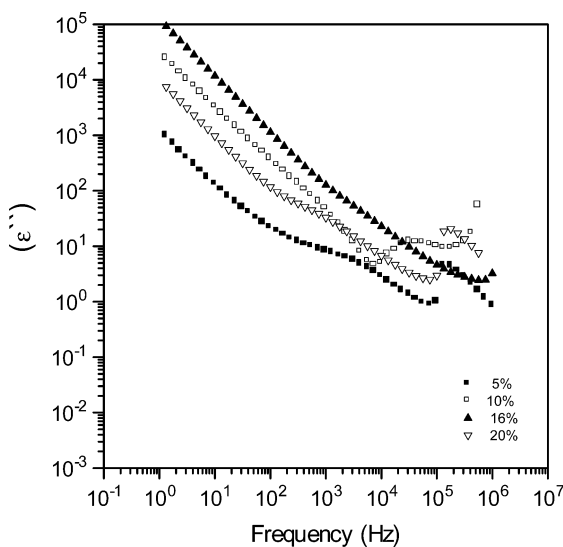


FIGURE 7 Log dielectric loss (ϵ'') versus frequency for polycarbosilazane-based CuCl_2 .

decreasing frequency. Therefore, the conduction mechanism in this system is by means of jumping (carrier hopping). The increase in the concentration up to 16% makes hopping between the chains easier, and thus results in an increase of conductivity. When the concentration exceeds 20%, CuCl_2 starts to form clusters that lead to an increase in the interaction distances, which makes hopping between chains more difficult, and thus causing a reduction of conductivity.

REFERENCES

- [1] Huber, C., Bangerter, F., Caser, W. R., and Weder, C., *J. Am. Chem. Soc.* **17**, 3857 (2001).
- [2] Alexandrova, L., Sansores, E., Martnez, E., Epinoza, E., and Gerasimov, R. G., *Polymer* **42**, 273 (2001).
- [3] Giroud-Godquin, A.M., *Chem. Rev.* **178–180**, 1485 (1998).
- [4] Nguyen, P., Gomez-Elipe, P., and Manner, I., *Chem. Rev.* **99**, 1515 (1999).
- [5] Sheats, J. E., Carraher, Jr., C. E., Pittmann, Jr., C. U., Zeldin, M., and Currell, B. (Eds.). (1990). *Inorganic and Metal-Containing Polymeric Materials*, Plenum Press, New York.
- [6] Bruce, D. W. and O'Hare, D. (Eds.) (1997). *Inorganic Materials*, 2nd ed. (John Wiley & Sons, Chichester).
- [7] Goodwin, J. C., Sessoli, R., Gatteschi, D., and Wernsdorfer, W., *J. Chem. Soc. Dalton Trans.*, **12**, 1835 (2000).
- [8] Clemente-Juan, J. M., Andres, H., Borrás-Almenar, J. J., Coronado, E., Gudel, H. U., Aebersold, M., Kearly, G., Buttner, H., and Zolliker, M., *J. Am. Chem. Soc.* **121**, 10021 (1999).
- [9] Nishide, H., Miyasaka, M., and Tsuchida, E., *Angew. Chem. Int. Ed.* **37**, 2400 (1998).
- [10] Snikanth, H., Hajndi, R., Chirinos, C., Sanders, J., Sampath, A., and Sudarshan, T. S., *Appl. Phys. Lett.* **79**, 3503 (2001).
- [11] Zou, W. D., Liu, Z. L., and Yao, K. L., *J. Magnetism and Magnetic Materials* **263**, 360 (2003).
- [12] Arafa, I. M., El-Ghanem, H., and Al-Shalabi, R., *J. Inorg. Organomet. Polym.* **13**, 69 (2003).
- [13] El-Ghanem, H. M., Abdul Jawad, S., Aljundi, J., Afaneh, F., and Arafa, I., *Polym. Int.* **52**, 1125 (2003).
- [14] Arafa, I. M. and El-Ghanem, H., *J. Macromol. Sci., Part A-Pure and Applied Chemistry.* **A(4) 9**, 975 (2003).
- [15] Arafa, I. M. and Al-Atrash, M., *J. Macromol. Sci., Part A-Pure and Applied Chemistry.* **A(39) 12**, 175 (2002).
- [16] Feng, K. and Mariam, Y. H., *Macromolecules* **24**, 4729 (1991).
- [17] Arafa, I. M., El-Ghanem, H., and Al-Shalabi, R., To be published.
- [18] Bodor, G. (1991). *Structural Investigation of Polymers*, Ellis Harwood (Engl. Ed.), England.
- [19] Skotheim, T. A. (Ed.) (1986). *Handbook of Conductive Polymers*, Vol. I and II, Marcel Dekker, New York.
- [20] Macedo, P. B., Moghniham, C. T., and Bose, R., *Phys. Chem. Glasses.* **13**, 71 (1972).
- [21] Lee, H., Liao, C. S., and Chen, S. A., *Makromol. Chem.* **194**, 2443 (1993).
- [22] Hourquebie, P. and Olemo, L., *Synth. Met.* **19**, 65 (1994).